

### General Description

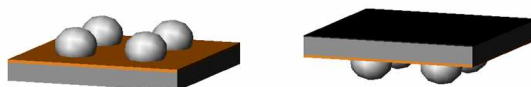
The AOC2800 uses advanced trench technology to provide excellent  $R_{SS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V while retaining a 12V  $V_{GS(MAX)}$  rating. It is ESD protected. This device is suitable for use as a uni-directional or bi-directional load switch, facilitated by its common-drain configuration.

### Product Summary

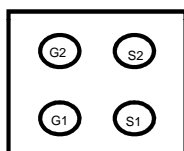
$V_{SS}$	30V
$I_D$ (at $V_{GS}=4.5V$ )	6A
$R_{SS(ON)}$ (at $V_{GS}=4.5V$ )	< 42m $\Omega$
$R_{SS(ON)}$ (at $V_{GS}=4.0V$ )	< 44m $\Omega$
$R_{SS(ON)}$ (at $V_{GS}=3.1V$ )	< 49m $\Omega$
$R_{SS(ON)}$ (at $V_{GS}=2.5V$ )	< 61m $\Omega$



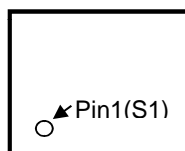
WLCSP 1.57x1.57\_4



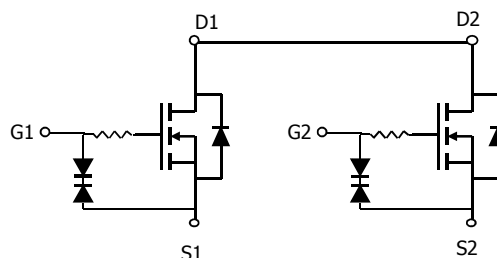
Bottom View



Top View



Equivalent Circuit



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Source-Source Voltage	$V_{SS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	V
Source Current (DC) <sup>Note1</sup>	$I_S$	6	A
Source Current (Pulse) <sup>Note2</sup>			
Power Dissipation <sup>Note1</sup>	$P_D$	1.3	W
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	$^\circ C$

**Note 1.** Mounted on minimum pad PCB

**Note 2.** PW <300  $\mu s$  pulses, duty cycle 0.5% max

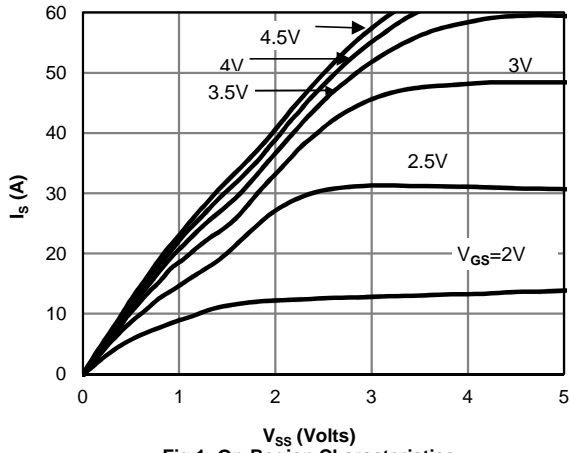
**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
BV <sub>SSS</sub>	Source-Source Breakdown Voltage	I <sub>S</sub> =250μA, V <sub>GS</sub> =0V, Test Circuit 6	30			V
I <sub>SSS</sub>	Zero Gate Voltage Source Current	V <sub>SS</sub> =20V, V <sub>GS</sub> =0V, Test Circuit 1			1	μA
		T <sub>J</sub> =55°C			5	
I <sub>GSS</sub>	Gate leakage current	V <sub>SS</sub> =0V, V <sub>GS</sub> = ±10V, Test Circuit 2		1	10	
BV <sub>GSO</sub>	Gate-Source Breakdown Voltage	V <sub>SS</sub> =0V, I <sub>G</sub> =±250μA, Test Circuit 7	±12			V
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>SS</sub> =V <sub>GS</sub> I <sub>S</sub> =250μA, Test Circuit 3	0.5	1	1.5	V
R <sub>SS(ON)</sub>	Static Source to Source On-Resistance <sup>Note</sup>	V <sub>GS</sub> =4.5V, I <sub>S</sub> =3A, Test Circuit 4		35	42	mΩ
		T <sub>J</sub> =125°C		53	63	
		V <sub>GS</sub> =4.0V, I <sub>S</sub> =3A, Test Circuit 4		37	44	
		V <sub>GS</sub> =3.1V, I <sub>S</sub> =3A, Test Circuit 4		41	49	
		V <sub>GS</sub> =2.5V, I <sub>S</sub> =3A, Test Circuit 4		49	61	
g <sub>FS</sub>	Forward Transconductance <sup>Note</sup>	V <sub>SS</sub> =5V, I <sub>S</sub> =3A, Test Circuit 3		21		S
V <sub>FSS</sub>	Diode Forward Voltage <sup>Note</sup>	I <sub>S</sub> =1A, V <sub>GS</sub> =0V, Test Circuit 5		0.7	1	V
<b>DYNAMIC PARAMETERS</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>SS</sub> =15V, f=1MHz,		984	1180	pF
C <sub>oss</sub>	Output Capacitance			93		pF
C <sub>riss</sub>	Reverse Transfer Capacitance			57		pF
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>SS</sub> =0V, f=1MHz		1.5		kΩ
<b>SWITCHING PARAMETERS</b>						
t <sub>D(on)</sub>	Turn-On DelayTime	V <sub>GS</sub> =10V, V <sub>SS</sub> =15V, R <sub>L</sub> =2.4Ω, R <sub>GEN</sub> =6Ω ,		320		ns
t <sub>r</sub>	Turn-On Rise Time			800		ns
t <sub>D(off)</sub>	Turn-Off DelayTime			3.8		μs
t <sub>f</sub>	Turn-Off Fall Time			3.6		μs
Q <sub>g</sub>	Total Gate Charge	V <sub>G1S1</sub> =4.5V, V <sub>SS</sub> =15V, I <sub>S</sub> =6A		9.1		nC

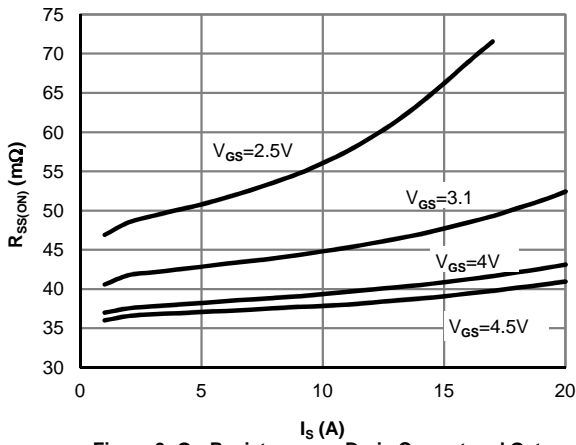
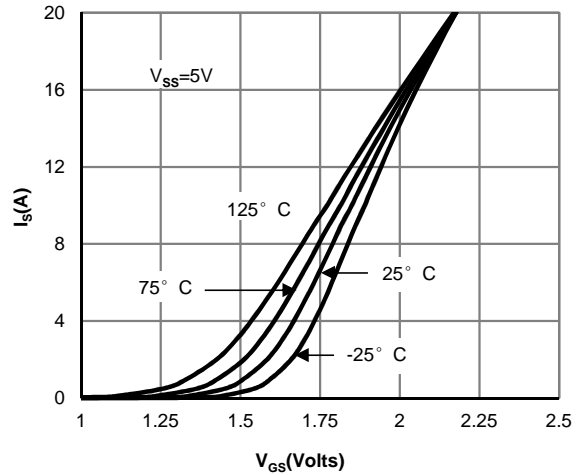
**Note: Pulsed**

THIS PRODUCT HAS BEEN DESIGNED AND QUALIFIED FOR THE CONSUMER MARKET. APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE

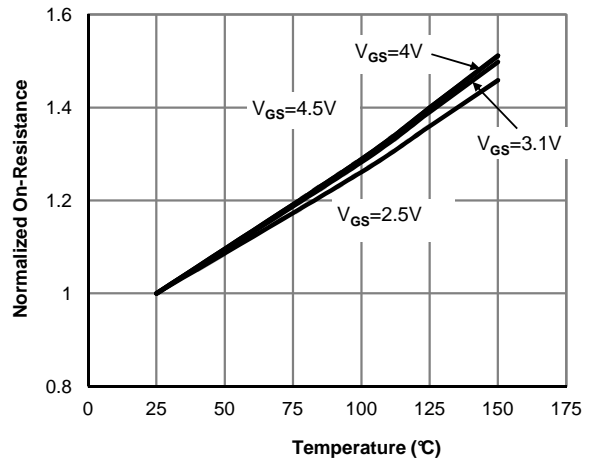
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



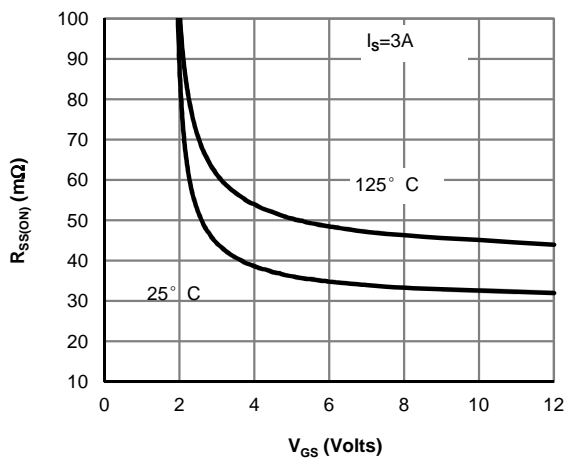
**Fig 1: On-Region Characteristics**



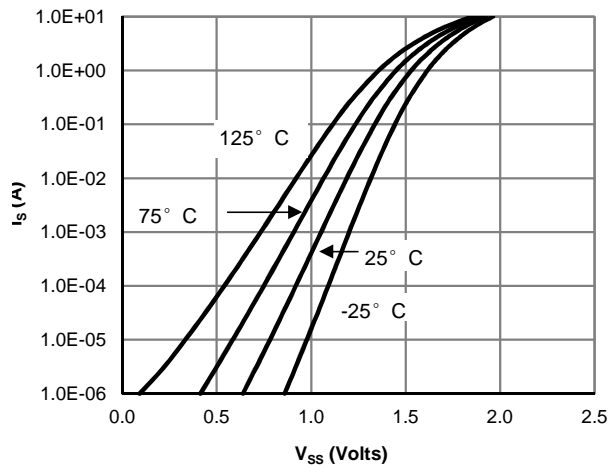
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage**



**Figure 4: On-Resistance vs. Junction Temperature**



**Figure 5: On-Resistance vs. Gate-Source Voltage**



**Figure 6: Body-Diode Characteristics**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

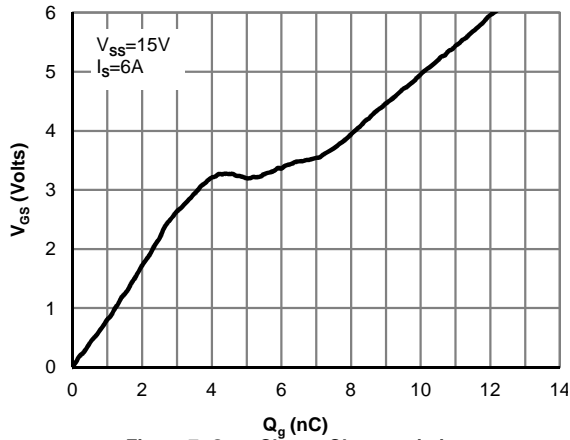


Figure 7: Gate-Charge Characteristics

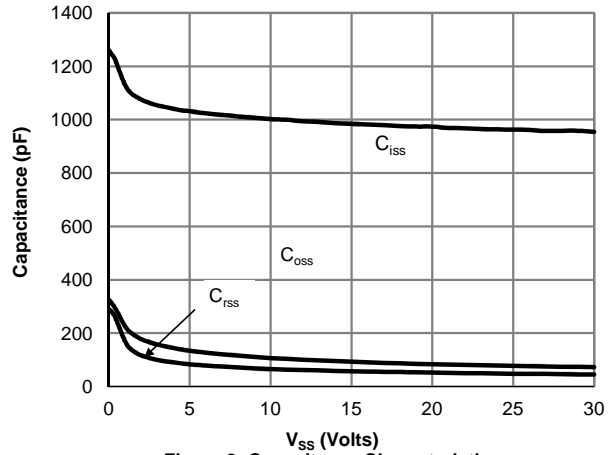


Figure 8: Capacitance Characteristics

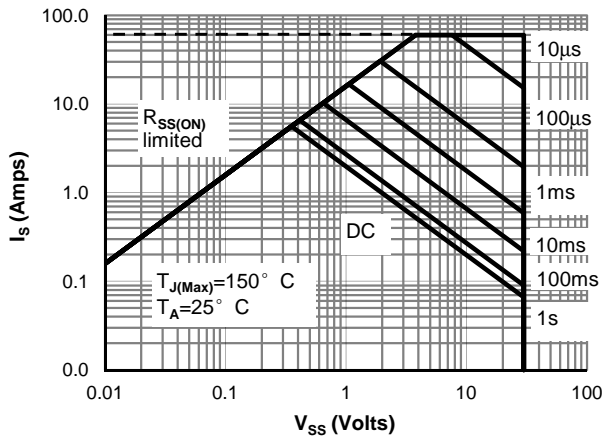


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

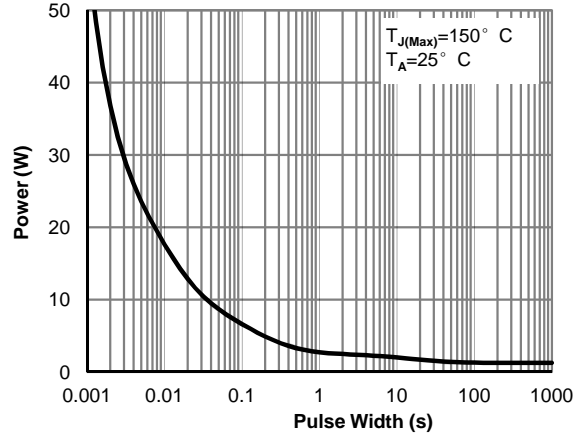


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

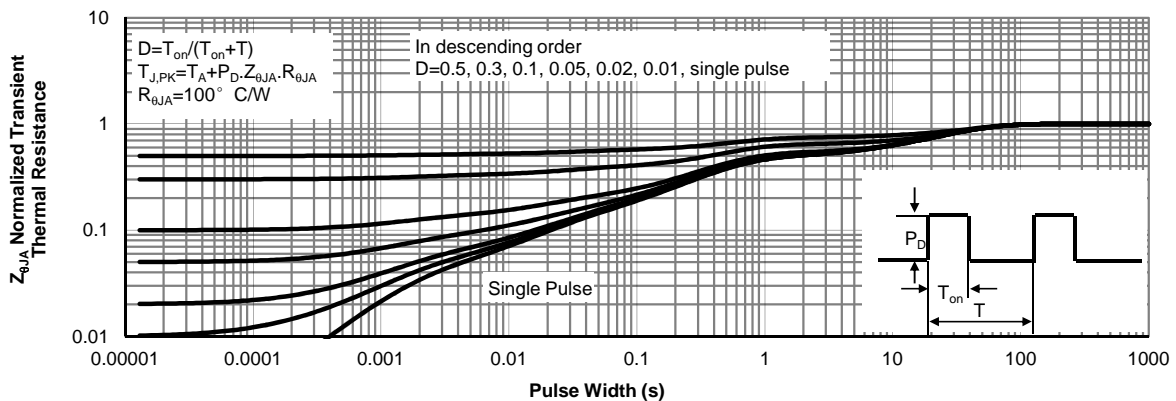


Figure 11: Normalized Maximum Transient Thermal Impedance

